



Customer No.: 27123

Docket No. 1232-5378

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Osamu TSUJII

Group Art Unit: 2882

Serial No.: 10/825,743

Examiner: TBA

Filed: April 16, 2004

For: RADIATION IMAGING APPARATUS

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to Rule 56, applicant hereby calls the attention of the Patent Office to the references listed on the attached Form PTO 1449. Copy(ies) of these references ☒ are attached

☐ were filed in related application U.S. Serial No(s) _____, filed _____, respectively.

- ☐ This document is being filed within three (3) months of the filing date of the application
- ☐ A check for the requisite fee of \$180 is enclosed.
- ☐ This document is being concurrently filed with the above-identified application
- ☐ This document is being concurrently filed with an Request for Continued Examination (RCE)
- ☒ This document is being filed prior to a first Office Action
- ☒ This document is accompanied by a Search Report/Communication cited in a corresponding PCT or foreign counterpart application.
- ☒ The Commissioner is hereby authorized to charge any additional fees which may be required for this Information Disclosure Statement, or credit any overpayment to Deposit Account No. 13-4500, Order No. 1232-5378. A DUPLICATE COPY OF THIS SHEET IS ATTACHED.

Respectfully submitted,
MORGAN & FINNEGAN, L.L.P.

Dated: November 11, 2004

By: _____

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FORM PTO-1449

INFORMATION DISCLOSURE CITATION

Attorney Docket:
1232-5378Serial No.:
10/825,743Applicant:
Osamu TSUJIIFiling Date:
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2882

U.S. PATENT DOCUMENTS

Examiner Initial	Patent Number	Issue Date	Name	Class	Sub-Class	Filing Date
	5,117,445	05/26/1992	Seppi et al.	378	65	07/02/1990
	2001/0019599	09/06/2001	Guendel	378	15	01/13/2001
	2002/0191736	12/19/2002	Shiota	378	4	05/30/2002
	2003/0007601	01/09/2003	Jaffray et al.	378	65	02/16/2001
	2003/0099328	05/29/2003	Jensen et al.	378	198	06/17/2002

FOREIGN PATENT DOCUMENTS

Examiner Initial	Patent Number	Publication Date	Country	Class	Sub-Class	Translation
	WO 01/60236	08/23/2001	PCT			<input type="checkbox"/> Yes <input type="checkbox"/> No
	1 163 880	12/19/2001	EP			<input type="checkbox"/> Yes <input type="checkbox"/> No
	101 18 183	11/07/2002	DE (w/English abstract)			<input type="checkbox"/> Yes <input checked="" type="checkbox"/> No
						<input type="checkbox"/> Yes <input type="checkbox"/> No
						<input type="checkbox"/> Yes <input type="checkbox"/> No

OTHER DOCUMENTS (Including Author, Title, Date, etc.)

Examiner

Date Considered

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP §609.
Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to Applicant.